Prober 4 Point Probe Resistivity

Short description: Four Point Probe Resistivity is designed for measuring sheet resistivity on sample with a flat surface. Making good measurements requires the 4 point probe to put even pressure on each point and assure the probes move straight up and down.

Including the SP4 Four Point Probe Head: SP4-62085TRY (for semi-conductor)

Spacing between tips: .0625" (1.6mm)
Pressure on each tips: 85 grams
Probe tip material: Tungsten Carbide
Tip radius: .0016" (40um)

Localisation: Welcome

Personne(s) ressource(s): Benoit Hubert, Pascal Simon,

Site Web: www.uclouvain.be/welcome
Contact: info-welcome@uclouvain.be